

ID	R _{Ds} (ON)(Typ)	VDSS
9A	0.25Ω	200V
• 100% a	s: vitching speed avalanche tested ved dv/dt capability	

Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS630T	T0-220	RS630T	Tube	50 PCS

Absolute Maximun Ratings Tc= 25°C unless otherwise specified

Symbol	Parameter	RS630T	Units
VDSS	Drain-to-Source Voltage	200	V
ID	Continuous Drain Current TC=25℃	9	А
IDM	Pulsed Drain Current	36	
PD	Power Dissipation	74	W
VGS	Gate- to- Source Voltage	±20	V
EAS	Single Pulse Avalanche Engergy L = 10mH,VDD = 50V, VGS = 10V, Tj = 25℃	115	mJ
	Maximum Temperature for Soldering		
TL TPKG Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds		300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS630T	Units	Test Conditions
RØJC	Junction-to-Case	1.7	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^\circ\!\mathrm{C}$
RθJA	Junction-to- Ambient	60		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25° C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	200			V	VGS=0V,ID=250μ Α
IDSS	Drain- to- Source Leakage Current			1	μA	VDS=200V,VGS= 0V
	Gate- to- Source Forward Leakage			100	- 4	VGS=20V ,VDS=0 V
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-20V ,VDS= 0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance		0.25	0.3	Ω	VGS=10V,ID=4.5 A
VGS(TH)	Gate Threshold Voltage	2.0		4.0	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		35			VDD=100V
trise	Rise Time		7			
td(OFF)	Turn- OFF Delay Time		98		nS	ID=9A RG=25Ω
tfall	Fall Time		32			



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		605			VGS= 0V
Coss	Output Capacitance		87		pF	VDS=25V
Crss	Reverse Transfer Capacitance		37			f=1.0MHz
Qg	Total Gate Charge		19			VDS= 160V
Qgs	Gate- to- Source Charge		3		nC	ID=9A
Qgd	Gate-to-Drain(" Miller") Charge		8			VGS=10V

Source- Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
IS	Continuous Source Current			9	Α	Integral pn- diode	
ISM	Maximum Pulsed Current			36	Α	in MOSFET	
VSD	Diode Forward Voltage			1.4	V	IS=4.5A,VGS=0V	
trr	Reverse Recovery Time		145		nS	VGS=0V	
Qrr	Reverse Recovery Charge		820		nC	IS=9A di/dt=100A/μs	

Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1%



Typical Feature Curve

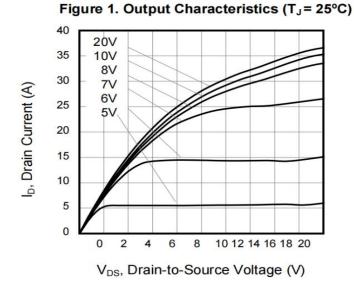


Figure 3. Drain Current vs. Temperature

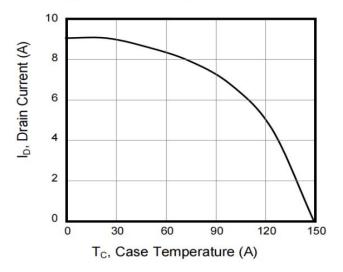


Figure 5. Transfer Characteristics

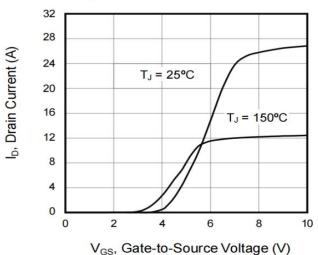
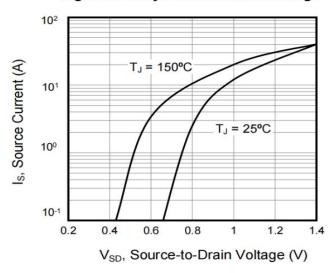
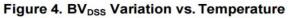


Figure 2. Body Diode Forward Voltage





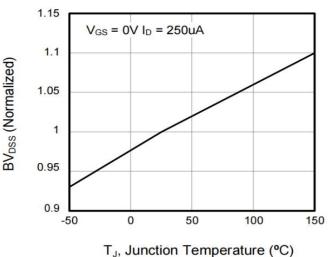
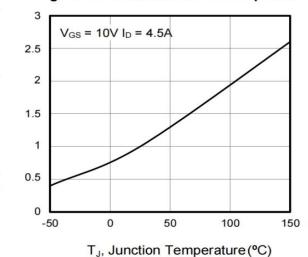


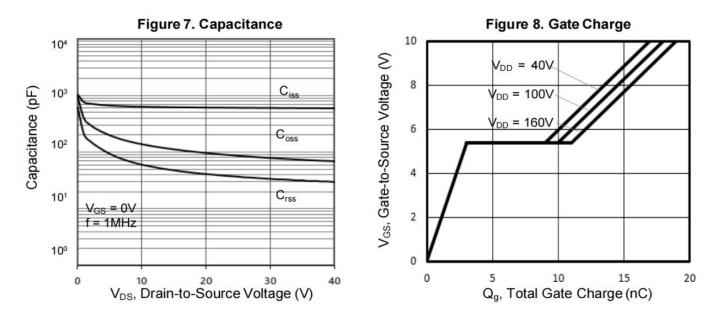
Figure 6. On-Resistance vs. Temperature



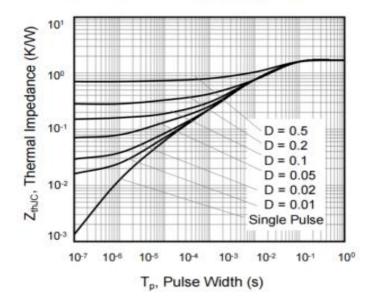
R_{DS(on)}, On-Resistance (Normalized)

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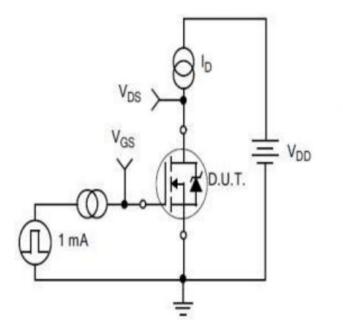








Test ircuits and Waveforms



VGS(TH)

VDS

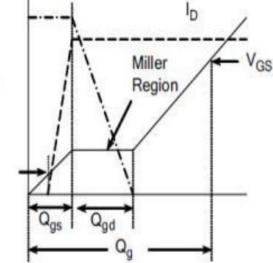


Figure A. Gate Charge Test Circuit

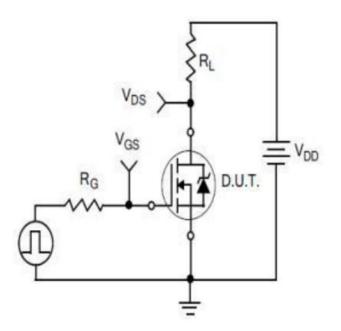


Figure C. Resistive Switching Test Circuit

Figure B. Gate Charge Waveform

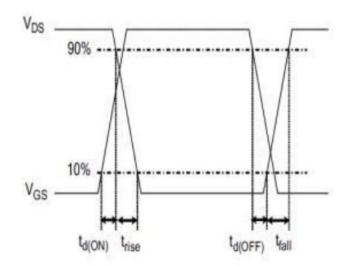
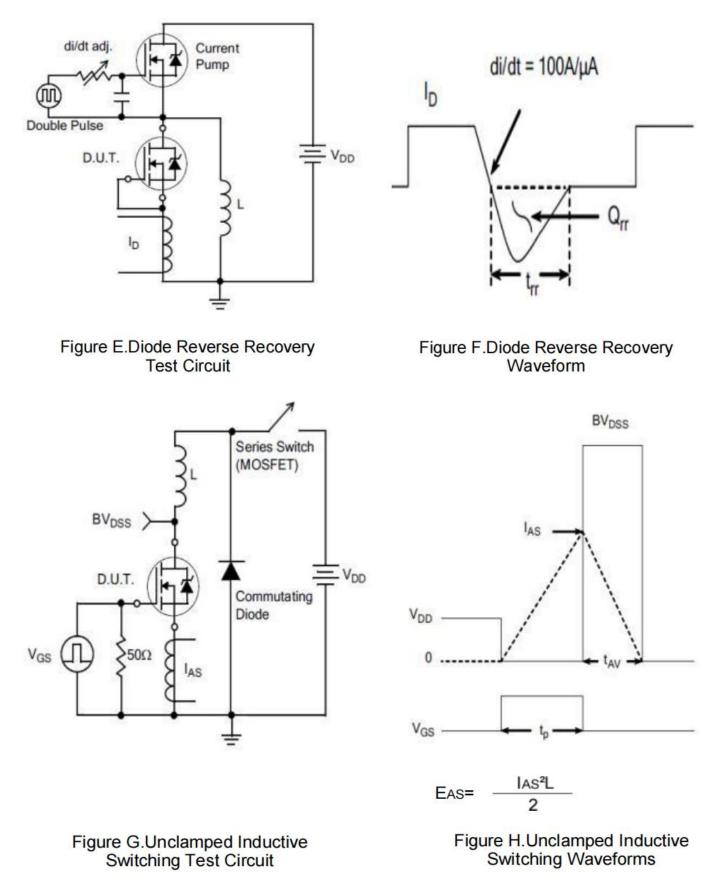


Figure D. Resistive Switching Waveforms

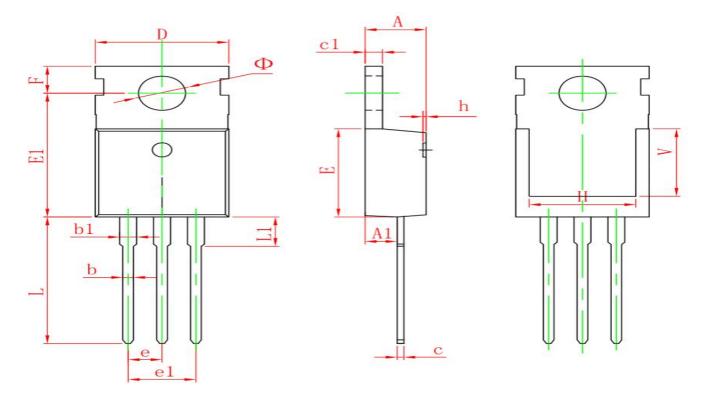


Test ircuits and Waveforms





Package outline drawing(TO-220 Unit: mm)



Symbol	Dimensions	In Millimeters	Dimension	s in inches
Symbol	Min.	Max.	Min.	Max.
А	4.400	4.600	0.173	0.181
A1	2.250	2.550	0.089	0.100
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
С	0.330	0.650	0.013	0.026
c1	1.200	1.400	0.047	0.055
D	9.910	10.250	0.390	0.404
E	8.950	9.750	0.352	0.384
E1	12.650	13.050	0.498	0.514
е	2.540 TYP.		0.100	TYP.
e1	4.980	5.180	0.196	0.204
F	2.650	2.950	0.104	0.116
Н	7.900	8.100	0.311	0.319
h	0.000	0.300	0.000	0.012
L	12.900	13.400	0.508	0.528
L1	2.850	3.250	0.112 0.128	
V	6.900	REF.	0.276	REF.
Φ	3.400	3.800	0.134	0.150



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